

<b>FORM PTO-1449</b> U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use several sheets if necessary)	ATTY. DOCKET NO.	SERIAL NO.
	500.36414CX1	Not yet assigned
	APPLICANT S. MITA, et al	
	FILING DATE November 13, 2001	GROUP 2634

11036 U.S. PTO  
09/986929  
11/13/01

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
CW	5 5 8 5 9 7 5	12/96	Bliss	360	65	
CW	6 0 6 9 8 5 6	5/00	Mita et al			

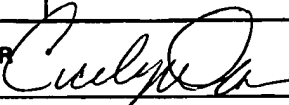
## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	ABSTRACT	
						YES	NO

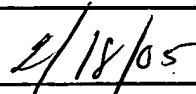
## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

CW	"Maximum Transition Run Codes for Data Storage Systems", IEEE Transactions on Magnetics, vol. 32, No. 5, September, 1996, pp. 3992-3994.
CW	"Maximum Likelihood Sequence Estimation of Digital Sequences in the Presence of Intersymbol Interference", IEEE Transactions on Information Theory, vol. IT-18, No. 3, May, 1972.

EXAMINER



DATE CONSIDERED



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	500.36414CX1	09/986,925
	APPLICANT S. MITA, et al	
	FILING DATE	GROUP
	November 13, 2001	Not assigned

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

**FOREIGN PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	ABSTRACT	
						YES	NO


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**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

EW	E. Eleftheriou et al, "Improving Performance of PRML/EPRML through Noise Prediction", IEEE Transactions on Magnetics, vol. 32, No. 5, September 1996, pp. 3968-3970.

EXAMINER <i>C. J. [Signature]</i>	DATE CONSIDERED <i>2/18/85</i>
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	<b>APPLICANT</b> <b>S. MITA, et al</b>	
	<b>FILING DATE</b> <b>November 13, 2001</b>	<b>GROUP</b>

## U.S. PATENT DOCUMENTS

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**GROUP**

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